

CMOS 40 MHz Monolithic 256×24 Color Palette RAM-DAC

ADV453

1.1 Scope.

This specification covers the detail requirements for Class B microcircuits in accordance with 1.2.1 of MIL-STD-883, provisions for the use of MIL-STD-883 in conjunction with complaint non-JAN devices. The device is a 40 MHz Monolithic 256×24 Color Palette RAM-DAC.

1.2 Part Number.

The complete part number per Table 1 of this specification is as follows:

Device	Part Number			
-1	ADV453TQ/883B			
2	ADV453TE/883B			

1.2.3 Case Outline.

See Appendix 1 of General Specification ADI-M-1000: package outline:

(\mathbf{X})	Package	Description	Lead Finish
Q	Q-40	40-Lead Dual-In-Line Package	Hot Solder DIP
E	E-44A	44-Lead LCC	Hot Solder DIP

1.3 Absolute Maximum Ratings.

Supply Voltage (V _{AA})+7.0 V
Digital Input Voltage (V _{IN}) to AGND
Analog Output Short Circuit Duration to Any Power Supply or Common Indefinite
Power Dissipation
Storage Temperature
Lead Temperature (Soldering 10 sec)
Junction Temperature+175°C

1.5 Thermal Characteristics.

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Thermal Resistance \theta_{JC} = See MIL-M-38510 Appendix C \theta_{JA} = 120°C/W for Q \theta_{JA} = 50°C/W for E
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Table 1.

		L	imit	Group A	Conditions ¹ $(-55^{\circ}C \le T_{A} \le +125^{\circ}C$	
Test	Symbol	Min	Max	Subgroups	unless otherwise noted)	Units
Resolution (Each DAC) Relative Accuracy (Each DAC)		8.0	8.0	4		Bits
Integral Nonlinearity	I _L	ļ	±2	1, 2, 3		LSB
Differential Nonlinearity	D_L		±1	1, 2, 3	Conversion Rate is 1 MHz	LSB
Gray Scale Error			±5	1, 2, 3	White Level Relative to Blank	% Gray Scale
Digital Input High Voltage	V _{IH}	2.4		7, 8		v
Digital Input Low Voltage	VIL		0.8	7, 8		v
Digital Input Current	I _{IN}		10	1, 2, 3	$V_{IN} = 0 \text{ V or } V_{AA}$	μА
Digital Input Capacitance ²	C _{IN}		10	4		pF
Digital Output High Voltage	V _{OH}	2.4		1, 2, 3	$I_{SOURCE} = 400 \mu A$	v
Digital Output Low Voltage	V _{OL}		0.4	1, 2, 3	I _{SINK} = 3.2 mA	v
Floating State Output Current	I _{OZ}		10	1, 2, 3	$V_{IN} = 0 \text{ V or } V_{AA}$	μА
Floating State Output Capacitance ²	CD _{OUT}		20	4		pF
Gray Scale Current Range		15	22	1, 2, 3		mA
Output Current White Level Relative to Blank		17.69	20.40	1, 2, 3		mA
White Level Relative to Black		16.74	18.50			
Black Level Relative to Blank		0.95	1.90			
Blank Level on IOR, IOB		0	50	1, 2, 3		μA
Blank Level on IOG		6.29	8.96			mA
Sync Level on IOG	1	0	50			μA
DAC to DAC Matching			6	1, 2, 3	White Level Relative to Blank	%
Output Compliance ³	V _{oc}	-1.0	1.4	1, 2, 3		v
Output Capacitance ²	CA _{OUT}		40	4	$I_{OUT} = 0 \text{ mA}$	pF
Voltage Reference Range ³		1.14	1.26	1, 2, 3		V
Power Supply Current	I _{AA}	-	300	1, 2, 3		mA
Power Supply Rejection Ratio (White Level Relative to Black)	PSRR		30	1, 2, 3	$V_{AA} = 5.0 \text{ V}$ Delta $V_{AA} = +5\% \text{ or } -5\%$ (0.5 V 1 kHz Sinewave Applied to V_{AA})	dB
CS C0, C1 Setup Time	t ₁	35		9, 10, 11		ns
CS C0, C1 Hold Time	t ₂	35		9, 10, 11		ns
RD, WR High Time	t ₃	25		9, 10, 11		ns .
RD Assert to Data Bus Driven	t ₄	2	_	9, 10, 11		ns
RD Assert to Data Valid	t ₅		100	9, 10, 11		ns
RD Negated to Data Bus Three Stated	t ₆		20	9, 10, 11		ns
RD, WR Low Time	t ₇	50		9, 10, 11		ns

Test	Symbol	Li: Min	mit Max	Group A Subgroups	Conditions¹ (-55°C ≤ T _A ≤ +125°C unless otherwise noted)	Units
Write Data Setup Time	t ₈	35		9, 10, 11		ns
Write Data Hold Time	t ₉	10		9, 10, 11		ns
Pixel and Control Setup Time	t ₁₀	7		9, 10, 11		ns
Pixel and Control Hold Time	t ₁₁	3		9, 10, 11		ns
Clock Cycle Time ³	t ₁₂	25		9, 10, 11		ns
Clock Pulse Width High Time	t ₁₃	7		9, 10, 11		ns
Clock Pulse Width Low Time	t ₁₄	7		9, 10, 11		ns
Analog Output Delay	t ₁₅		30	9, 10, 11	CLK = 4 MHz	ns
Analog Output Rise/Fall Time	t ₁₆		8	9, 10, 11	CLK = 4 MHz	ns
Pipeline Delay ³	t _{PD}		2×t ₁₂	9, 10, 11		ns
Analog Output Skew	t _{SK}		2	9, 10, 11	CLK = 4 MHz	ns

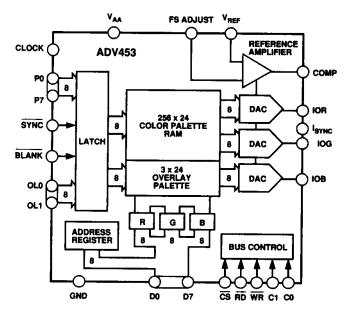
NOTES $^{1}V_{AA} = +4.75$ V to +5.25 V, $V_{REF} = 1.235$ V, $R_{SET} = 280$ Ω , I_{SYNC} connected to IOG, unless otherwise specified. 2 Tested on initial release and after any redesign which may affect this parameter.

³These tests are done on a pass/fail basis only. Minimum and/or maximum conditions (as appropriate) are used as input conditions.

⁴Digital input values are 0 to 3 V, with input rise/fall time, < 3 ns measured between the 10% and 90% points. Timing reference points are at 50% for inputs an outputs. See Figure 1.

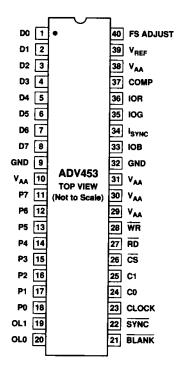
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3.2.1 Functional Block Diagram and Terminal Assignments.



Q Package (DIP)

E Package (LCC)



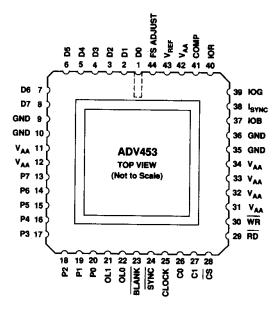


Table 2. Electrical Test Requirements

MIL-STD-883 Test Requirements	Subgroups (Per Method 5005 Table 1)
Interim Electrical Parameters (Method 5004)	1, 7, 9
Final Electrical Test Parameters (Method 5004)	1*, 2, 3, 7, 8, 9, 10, 11
Group A Test Requirements (Method 5005)	1, 2, 3, 7, 8A, 8B, 9, 10, 11
Group C and D Endpoint Electrical Parameters (Method 5005)	1, 7, 9

^{*}PDA applies to subgroup 1.

4.3.2 Group C and D Inspections

- a. Endpoint electrical parameters shall be as specified in Table 2 herein.
- b. Steady-state life test conditions, method 1005 of MIL-STD-883.

Test Condition A, B, C or D using the circuit in E Package Drawing.

 $T_A = 125^{\circ}C$, Min

Test Duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

5. Packing

5.1 Packaging Requirements

The requirements for packaging shall be in accordance with MIL-M-38510.

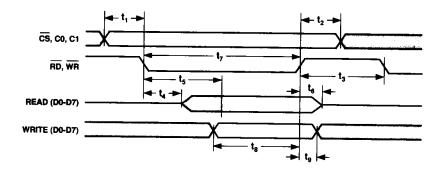
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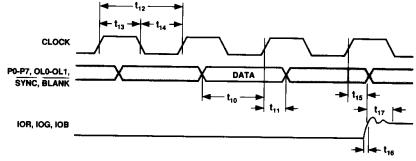
Table 3.

Description	IOG (mA)	IOR, IOB (mA)	SYNC	BLANK	DAC Input Data
White Level	26.67	19.05	1	1	FFH
Video	Video + 9.05	Video + 1.44	1	1	Data
Video to Blank	Video + 1.44	Video + 1.44	0	1	Data
Black Level	9.05	1.44	1	1	00H
Black to Blank	1.44	1.44	0	1	00H
Blank Level	7.62	0	1	ō	XXH
SYNC Level	0	0	0	0	XXH

Notes

- Typical with full scale IOG = 26.67 mA.
 V_{REF} = +1.235 V, R_{SET} = 280 Ω. I_{SYNC} connected to IOG.





NOTES

- 1. OUTPUT DELAY (t_{16}) MEASURED FROM THE 50% POINT OF THE RISING EDGE OF CLOCK TO THE 50% POINT OF FULL SCALE TRANSITION.
- 2. SETTLING TIME (${\rm t_{17}}$) MEASURED FROM THE 50% POINT OF FULL SCALE TRANSITION TO THE OUTPUT REMAINING WITHIN ± 1 LSB.
- 3. OUTPUT RISE/FALL TIME (t_{16}) MEASURED BETWEEN THE 10% AND 90% POINTS OF FULL SCALE TRANSITION.

Figure 1. Timing Diagrams